

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

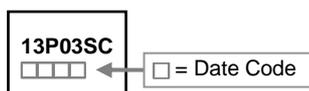
DESCRIPTION

The SSG13P03 uses advanced trench technology to provide excellent on-resistance, low gate charge and operation with gate voltages as low as 2.5V. The device is suitable for use as a load switch or in PWM applications. It may be used in a common drain arrangement to form a bidirectional blocking switch.

FEATURES

- Simple Drive Requirement
- Lower On-resistance
- Low Gate Charge

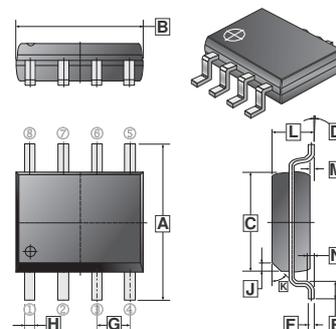
MARKING



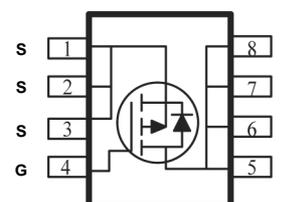
PACKAGE INFORMATION

Package	MPQ	Leader Size
SOP-8	3K	13' inch

SOP-8



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	5.80	6.20	H	0.35	0.49
B	4.80	5.00	J	0.375 REF.	
C	3.80	4.00	K	45°	
D	0°	8°	L	1.35	1.75
E	0.40	0.90	M	0.10	0.25
F	0.19	0.25	N	0.25 REF.	
G	1.27 TYP.				



MAXIMUM RATINGS (T_A = 25°C unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V _{DS}	-30	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current @ V _{GS} =10V ¹	I _D	T _A = 25°C	-13
		T _A = 70°C	-8.2
Pulsed Drain Current ²	I _{DM}	-50	A
Single Pulse Avalanche Energy ³	E _{AS}	273	mJ
Avalanche Current	I _{AS}	-42	A
Total Power Dissipation ⁴	P _D	1.5	W
Operating Junction & Storage Temperature Range	T _J , T _{STG}	-55 ~ 150	°C
Thermal Resistance Ratings			
Thermal Resistance Junction-Ambient ¹ (Max.)	R _{θJA}	85	°C / W
Thermal Resistance Junction-Case ¹ (Max.)	R _{θJC}	50	°C / W

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition	
Static							
Drain-Source Breakdown Voltage	BV_{DSS}	-30	-	-	V	$V_{GS}=0V, I_D = -250\mu A$	
Gate-Threshold Voltage	$V_{GS(th)}$	-1	-	-2.5	V	$V_{DS}=V_{GS}, I_D = -250\mu A$	
Forward Transfer Conductance	G_{fs}	-	32	-	S	$V_{DS} = -5V, I_D = -8A$	
Gate-Body Leakage	I_{GSS}	-	-	± 100	nA	$V_{GS} = \pm 20V$	
Drain-Source Leakage Current	I_{DSS}	$T_J = 25^\circ\text{C}$	-	-	-1	μA	$V_{DS} = -24V, V_{GS} = 0$
		$T_J = 55^\circ\text{C}$	-	-	-5		
Drain-Source On-Resistance ²	$R_{DS(ON)}$	-	-	15	m Ω	$V_{GS} = -10V, I_D = -8A$	
		-	-	20		$V_{GS} = -4.5V, I_D = -6A$	
Total Gate Charge	Q_g	-	21.8	-	nC	$I_D = -8A$ $V_{DS} = -15V$ $V_{GS} = -4.5V$	
Gate-Source Charge	Q_{gs}	-	7.9	-			
Gate-Drain ("Miller") Charge	Q_{gd}	-	6.5	-			
Turn-On Delay Time ²	$T_{d(on)}$	-	10	-	nS	$V_{DS} = -15V$ $I_D = -8A$ $V_{GS} = -10V$ $R_G = 3.3\Omega$	
Rise Time	T_r	-	9.6	-			
Turn-Off Delay Time	$T_{d(off)}$	-	86	-			
Fall Time	T_f	-	9.6	-			
Input Capacitance	C_{iss}	-	2215	-	pF	$V_{GS} = 0V$ $V_{DS} = -15V$ $f = 1.0\text{MHz}$	
Output Capacitance	C_{oss}	-	310	-			
Reverse Transfer Capacitance	C_{rss}	-	237	-			
Gate Resistance	R_G	-	9	18	Ω	$f = 1.0\text{MHz}$	
Avalanche Characteristics							
Single Pulse Avalanche Energy ⁵	EAS	63	-	-	mJ	$V_{DD} = -25V, L = 0.1\text{mH}, I_{AS} = -21A$	
Source-Drain Diode							
Forward On Voltage ²	V_{DS}	-	-	-1	V	$I_S = -1A, V_{GS} = 0V, T_J = 25^\circ\text{C}$	
Continuous Source Current ^{1,6}	I_S	-	-	-13	A	$V_G = V_D = 0V$	
Pulsed Source Current ^{2,6}	I_{SM}	-	-	-50	A	Force Current	
Reverse Recovery Time	T_{RR}	-	16	-	nS	$I_F = -8A, dI/dt = 100A/\mu s,$	
Reverse Recovery Charge	Q_{RR}	-	8	-	nC	$T_J = 25^\circ\text{C}$	

Notes:

1. surface mounted on a 1 inch² FR-4 board with 2OZ copper. 125 $^\circ\text{C}/\text{W}$ when mounted on Min. copper pad.
2. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. The EAS data shows Max. rating . The test condition is $V_{DD} = -25V, V_{GS} = -10V, L = 0.1\text{mH}, I_{AS} = -50A$
4. The power dissipation is limited by 150 $^\circ\text{C}$ junction temperature
5. The Min. value is 100% EAS tested guarantee.
6. The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

CHARACTERISTIC CURVES

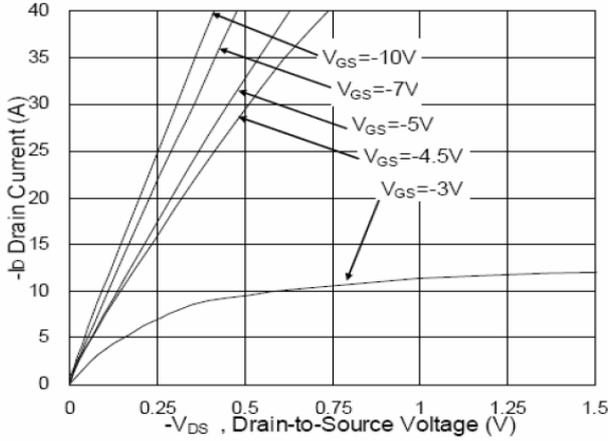


Fig.1 Typical Output Characteristics

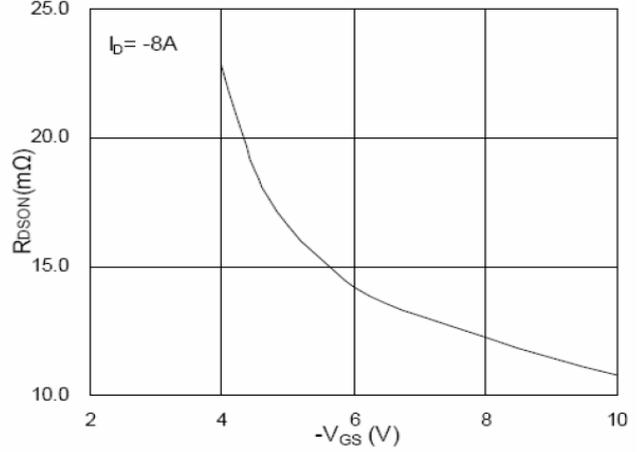


Fig.2 On-Resistance vs. G-S Voltage

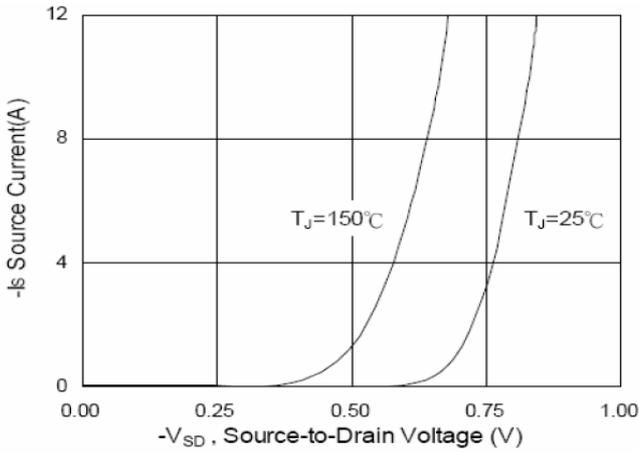


Fig.3 Forward Characteristics of Reverse

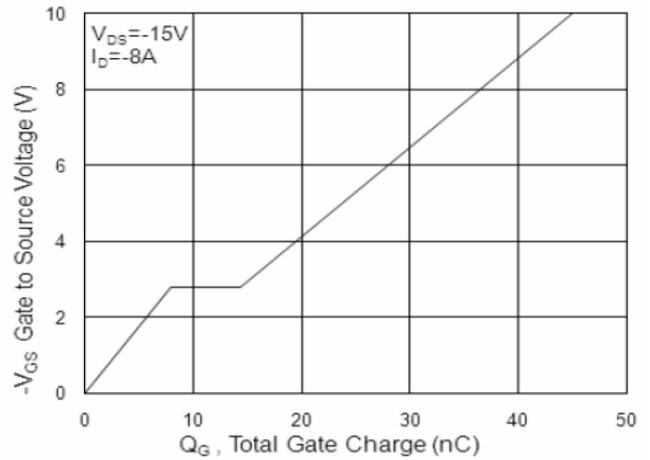


Fig.4 Gate-Charge Characteristics

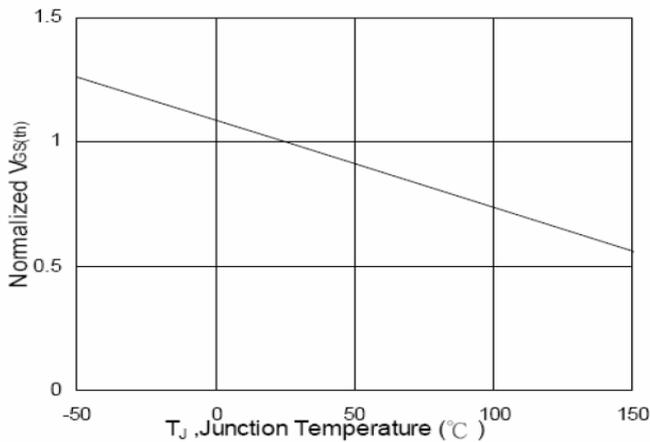


Fig.5 Normalized V_{GS(th)} vs. T_J

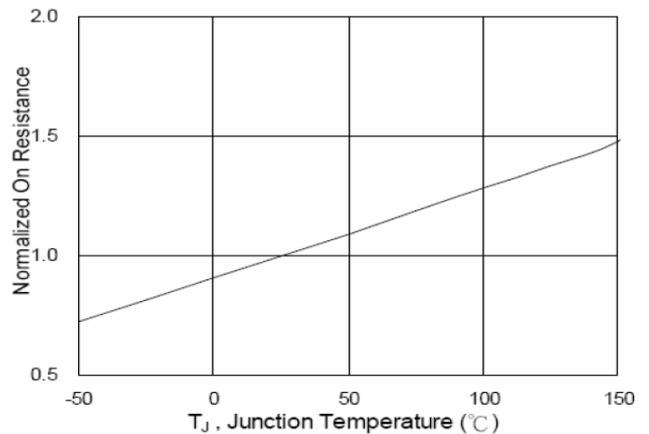


Fig.6 Normalized R_{DS(on)} vs. T_J

CHARACTERISTIC CURVES

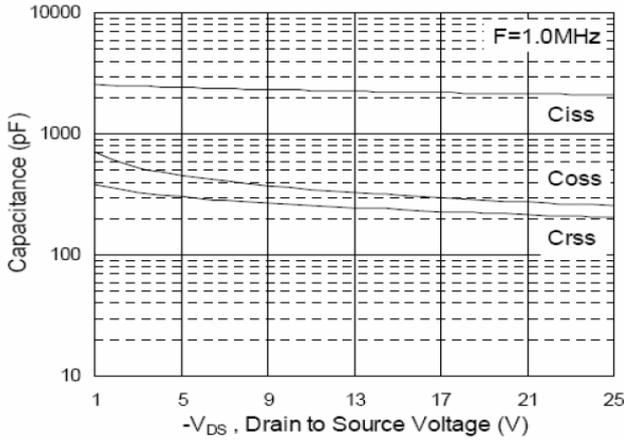


Fig.7 Capacitance

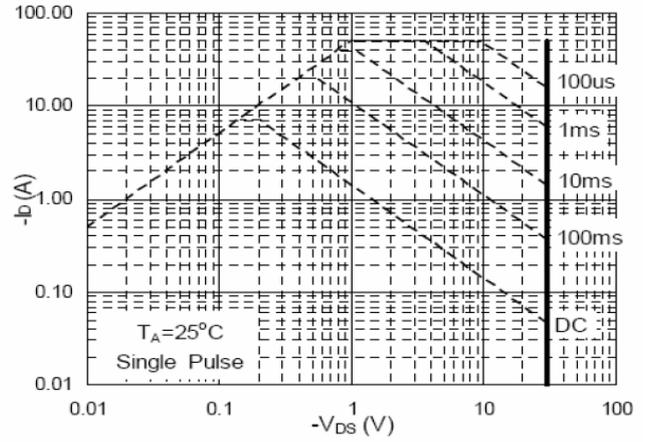


Fig.8 Safe Operating Area

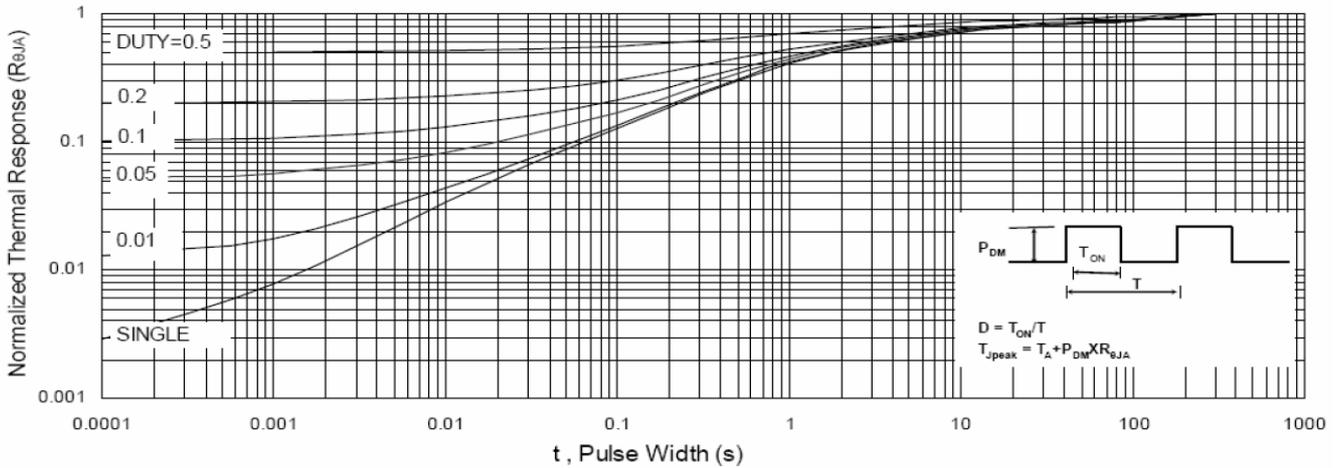


Fig.9 Normalized Maximum Transient Thermal Impedance

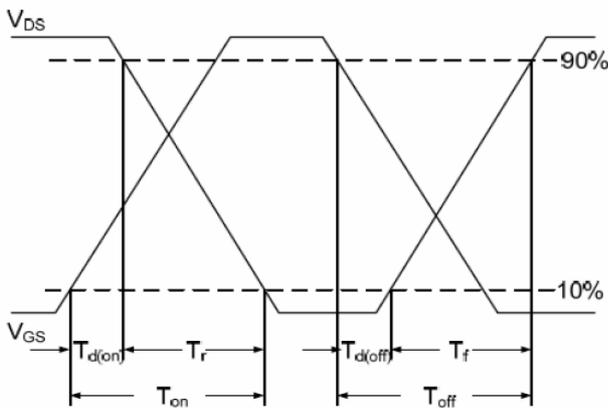


Fig.10 Switching Time Waveform

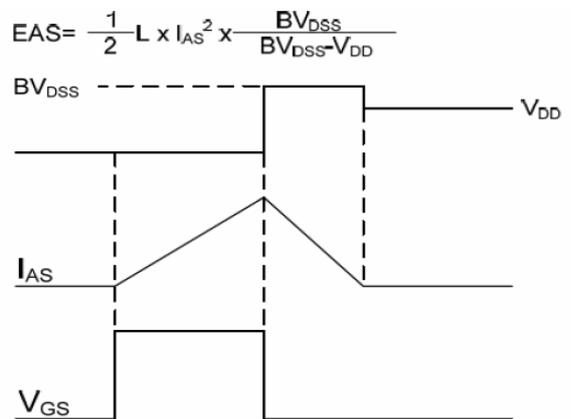


Fig.11 Unclamped Inductive Switching Wave